

No. DAT-P-114/01-01



TEST REPORT

No. 2009BTH0104

Product Name	850/900/1800/1900 GSM/GPRS Mobile Phone	
Model	Xenium X810	
Client	Shenzhen Sang Fei Consumer Communications Co.,Ltd.	
Classification of test	Type Approval	

Telecommunication Metrology Centerof Ministry of Information Industry

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	850/900/1800/1900	Model	
Product Name	oduct Name GSM/GPRS Mobile Phone		Xenium X810
Client	Shenzhen Sang Fei Consumer Communications Co., Ltd.		
Manufacturer	Shenzhen Sang Fei Consumer Communications Co., Ltd.		
Arrival Date of sample	December 31, 2008	Carrier of the samples	Helen Lin
Quantity of the samples	2	Date of product	1
Series number	359928020001540, 359928020001003		
Standard(s)	FCC Part 15, Subpart C: 15.205 Restricted bands of operation; 15.209 Radiated emission limits; general requirements; 15.247 Operation within the bands 902–928MHz, 2400–2483.5 MHz, and 5725–5850 MHz. ANSI C63.4- 2003 FCC Public Notice DA 00-705, March 2000		
Conclusion	9 test cases were done. The test results are shown in the clause 6 and annex B. The samples passed all the tests required by the client. Date of issue: 2009-02-27		
Comment	The test result relates only to the tested samples.		

Approved by	路地本	_Reviewed by_	30/2	Tested by N
	(Lu Bingsong)		(Gao Hong)	(Sun Zhenyu)

(Lu Bingsong - Deputy Director of the laboratory)

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1. Competence and Warranties

Telecommunication Metrology Center of Ministry of Information Industry is a test laboratory accredited by DAR (DATech) – Deutschen Akkreditierungs Rat (The German Accreditation Body Technology) for the tests indicated in the Certificate No. **DAT-P-114/01-01**.

Telecommunication Metrology Center of Ministry of Information Industry is a test laboratory accredited by CNAS–China national Accreditation Service for Conformity Assessment, for the tests indicated in the Certificate No. **L0442**.

Telecommunication Metrology Center of Ministry of Information Industry (hereinafter TMC of MII) is a test laboratory competent to carry out the tests described in this test report.

TMC of MII guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at **TMC of MII** at the time of execution of the test.

TMC of MII is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test.

2. Testing Laboratory

2.1. Testing Location

Name of Company :	Telecommunication Metrology Center of Ministry of Information
	Industry
Address:	No 52, Hua Yuanbei Road, Haidian District, Beijing, P.R.China
Postal Code:	100083
Telephone:	+86-10-62303288
Fax:	+86-10-62304793

2.2. Testing Environment

Shielding Room1 (6.0 meters×3.0 meters×2.7 meters) did not exceed following limits along the conducted RF performance testing:

Temperature	Min. = 15 °C, Max. = 30 °C
Relative humidity	Min. = 30 %, Max. = 60 %
Shielding effectiveness	> 110 dB
Ground system resistance	< 0.5 Ω
Uniformity of field strength	Between 0 and 6 dB, from 80MHz to 3000 MHz

Control room did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. =30 %, Max. = 60 %

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Shielding effectiveness	> 110 dB
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω

Fully-anechoic chamber1 (6.8 meters×3.08 meters×3.53 meters) did not exceed following limits along the EMC testing:

Temperature	Min. = 15 $^{\circ}$ C, Max. = 30 $^{\circ}$ C
Relative humidity	Min. = 30 %, Max. = 60 %
Shielding effectiveness	> 110 dB
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω
Uniformity of field strength	Between 0 and 6 dB, from 80MHz to 3000 MHz

Shielding Room2 (7.30 meters×4.00 meters×3.80 meters) did not exceed following limits along the EMC testing:

Temperature	Min. = 15 $^{\circ}$ C, Max. = 30 $^{\circ}$ C
Relative humidity	Min. = 35 %, Max. = 60 %
Shielding effectiveness	> 110 dB
Electrical insulation	> 10 kΩ
Ground system resistance	< 0.5 Ω
Uniformity of field strength	Between 0 and 6 dB, from 80MHz to 3000 MHz

2.3. Testing Period

The performed test started on 6th January, 2009 and finished on 27th February, 2009.

3. Applicant Information

3.1. Client information

Name of Company:	Shenzhen Sang Fei Consumer Communications Co.,Ltd.	
Address /Doots	11 Science & Technology Rd., Shenzhen Hi-tech Industrial Park,	
Address /Post:	Nanshan District, Shenzhen 518057	
City:	Shenzhen	
Postal Code:	518057	
Country:	China	
Telephone:	0755-26633217	
Fax:	0755-26635272	

3.2. Manufacturer information

Name of Company:	Shenzhen Sang Fei Consumer Communications Co.,Ltd.			
Address /Deets	11 Science & Technology Rd., Shenzhen Hi-tech Industrial Park,			
Address /Post:	Nanshan District, Shenzhen 518057			
City:	Shenzhen			
Postal Code:	518057			
Country:	China			

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Telephone:	0755-26633217
Fax:	0755-26635272

4. Equipment Under Test (EUT) and Ancillary Equipment (AE)

4.1. About EUT

Product name:	850/900/1800/1900 GSM/GPRS Mobile Phone
Model:	Xenium X810
FCC ID:	VQRCTX810
With Bluetooth	Yes
EUT operating voltage- Normal:	3.7
Extreme Low Voltage:	3.5
Extreme High Voltage:	4.2,
Extreme temperature:	-20℃ / + 55℃

Note: please refer to ANNEX A in this test report for Photographs of EUT.

4.2. Internal Identification of EUT used during the test

	<u> </u>				
EUT ID*	SN or IMEI	HW Version	SW Version		
EUT1	359928020001540	PR1	XFLAT2_M6229X_081205_V10		
EUT2	359928020001003	PR1	XFLAT2_M6229X_081205_V10		

^{*}EUT ID is used to identify the test sample in the lab internally.

4.3. Internal Identification of AE used during the test

AE ID*	Description	Туре	SN
AE1	Switching adapter	DSA-5W-05 FUS 050065	/
AE2	Li-ion Battery	AB1050DWM	/

^{*}AE ID: is used to identify the test sample in the lab internally.

5. Reference Documents

5.1. Documents supplied by applicant

EUT feature information is supplied by the client or manufacturer, which is the basis of testing.

5.2. Reference Documents

The following documents listed in this section are referred for testing.

Reference	Title	Version
	FCC CFR 47, Part 15, Subpart C:	
	15.205 Restricted bands of operation;	May 4, 2007
FCC Part15	15.209 Radiated emission limits, general requirements;	Edition
	15.247 Operation within the bands 902–928MHz,	
	2400-2483.5 MHz, and 5725-5850 MHz.	
	Methods of Measurement of Radio-Noise Emissions from	
ANSI C63.4	Low-Voltage Electrical and Electronic Equipment in the	2003
	Range of 9 kHz to 40 GHz	

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FCC Public Notice	Filing and Measurement Guidelines for Frequency	March 2000
DA 00-705	Hopping Spread Spectrum Systems	March 2000

6. Test Results

6.1. Summary of Test Results

Abbreviations used in this clause:

P Pass

F Fail

NA not applicable

NM not measured

SUMMARY OF MEASUREMENT RESULTS	Sub-clause	Verdict
Peak Output Power - Conducted	15.247 (b)(1)	Р
Frequency Band Edges	15.247 (d)	Р
Conducted Emission	15.247 (d)	Р
Radiated Emission	15.247, 15.205, 15.209	Р
Time of Occupancy (Dwell Time)	15.247 (a) (1)(iii)	Р
20dB Bandwidth	15.247 (a)(1)	NA
Carrier Frequency Separation	15.247 (a)(1)	Р
Number of hopping channels	15.247 (a)(b)(iii)	Р
AC Powerline Conducted Emission	15.107, 15.207	Р

Please refer to **ANNEX B** for detail.

6.2. Statements

TMC has evaluated the test cases requested by the client/manufacturer as listed in section 6.1 of this report for the EUT specified in section 4 according to the standards or reference documents listed in section 5.2.

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7. Test Equipments

Conducted test system

No.	Equipment	Model	Serial Number	Manufacturer	Calibration Due date
1	Vector Signal Analyzer	FSQ26	200136	Rohde & Schwarz	2010-01-15
2	Bluetooth Tester	CBT	100135	Rohde & Schwarz	2009-11-12
3	Power Meter	NRVD	101078	Rohde & Schwarz	/
4	DIODE Power Sensor	NRV-Z15	100103	Rohde & Schwarz	2009-09-02
5	Test Receiver	ESS	847151/015	Rohde & Schwarz	2009-10-30
6	LISN	ESH2-Z5	829991/012	Rohde & Schwarz	2009-08-13

Radiated emission test system

No.	Equipment	Model	Serial Number	Manufacturer	Calibration Due date
1	Test Receiver	ESI40	831564/002	Rohde & Schwarz	2010-02-12
2	BiLog Antenna	3142B	9908-1403	EMCO	2009-03-15
3	Dual-Ridge Waveguide Horn Antenna	3115	9906-5827	EMCO	2009-12-25
4	Universal Radio Communication Tester	CMU200	105948	Rohde & Schwarz	2009-08-15

Anechoic chamber

Fully anechoic chamber by Frankonia German.

ANNEX A: Photograph of EUT

External Photo



Mobile Phone



Mobile Phone



Mobile Phone



Mobile Phone



Battery



Battery



Adapter



Tag on the Adapter

Internal Photo



Mobile phone Disassembly



Mobile phone Disassembly



Mobile Phone Disassembly

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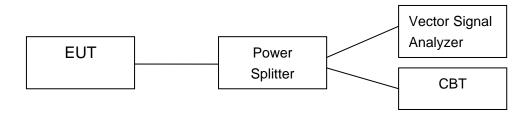
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ANNEX B: MEASUREMENT RESULTS

B.1 Measurement Method

B.1.1 Conducted Cases

- 1). Connect the EUT to the test system correctly.
- 2). Set the EUT to the required work mode (Transmitter, receiver or transmitter & receiver).
- 3). Set the EUT to the required channel.
- 4). Set the EUT hopping mode (hopping or hopping off).
- 5). Set the spectrum analyzer to start measurement.
- 6). Record the values. Vector Signal Analyzer



B.1.2 Radiated Emission

In the case of radiated emission, the used settings are as follows,

Sweep frequency from 30 MHz to 1GHz, RBW = 100 kHz, VBW = 300 kHz;

Sweep frequency from 1 GHz to 26GHz, RBW = 1MHz, VBW = 1MHz;

B.2 Peak Output Power - Conducted

Measurement Limit:

Standard	Limit (dBm)	
FCC Part 15.247(b)(1)	< 30	

Measurement Results:

Channel	Ch 0 2402 MHz	Ch 39 2441 MHz	Ch 78 2480 MHz	Conclusion
Peak Conducted				
Output Power	-4.12	-3.75	-1.61	Р
(dBm)				

Conclusion: PASS

B.3 Frequency Band Edges

Measurement Limit:

Standard	Limit (dBc)
FCC 47 CFR Part 15.247 (d)	> 20

Measurement Result:

	Channel	Hopping	Band Edge	Power (dBc)	Conclusion
Ī	0	Hopping OFF	Fig.1	55.62	Р

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	Hopping ON	Fig.2	54.51	Р
70	Hopping OFF	Fig.3	44.42	Р
78	Hopping ON	Fig.4	54.65	Р

Conclusion: PASS

B.4 Conducted Emission

Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247 (d)	20dB below peak output power in 100 kHz
	bandwidth

Measurement Results:

Channel	Frequency Range	Test Results	Conclusion
Ch O	Center Frequency	Fig.5	Р
Ch 0 2402 MHz	30 MHz ~ 1 GHz	Fig.6	Р
2402 111112	1 GHz ~ 26 GHz	Fig.7	Р
Ch 20	Center Frequency	Fig.8	Р
Ch 39 2441 MHz	30 MHz ~ 1 GHz	Fig.9	Р
21111111112	1 GHz ~ 26 GHz	Fig.10	Р
Ch 79	Center Frequency	Fig.11	Р
Ch 78 2480 MHz	30 MHz ~ 1 GHz	Fig.12	Р
2 100 WII 12	1 GHz ~ 26 GHz	Fig.13	Р

Conclusion: PASS

B.5 Radiated Emission

Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247, 15.205, 15.209	20dB below peak output power

In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a) (see § 15.205(c)).

Limit in restricted band:

Frequency of emission	Field strength(uV/m)	Field strength(dBuV/m)
(MHz)		
30-88	100	40
88-216	150	43.5
216-960	200	46
Above 960	500	54

Measurement Results:

Channel	Frequency Range	Test Results	Conclusion
Ch 0	30 MHz ~ 1 GHz	Fig.14	Р
2402 MHz	1 GHz ~ 4 GHz	Fig.15	Р

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	4 GHz ~ 18 GHz	Fig.16	Р
Ch 20	30 MHz ~ 1 GHz	Fig.17	Р
Ch 39 2441 MHz	1 GHz ~ 4 GHz	Fig.18	Р
2111111112	4 GHz ~ 18 GHz	Fig.19	Р
Ch 78	30 MHz ~ 1 GHz	Fig.20	Р
2480 MHz	1 GHz ~ 4 GHz	Fig.21	Р
2 100 111112	4 GHz ~ 18 GHz	Fig.22	Р
Car all abancals	2.45GHz~2.5GHz	Fig.23	Р
For all channels	18 GHz ~ 26 GHz	Fig.24	Р

Conclusion: PASS

B.6 Time of Occupancy (Dwell Time)

Measurement Limit:

Standard	Limit (ms)
FCC 47 CFR Part 15.247(a) (1)(iii)	< 400

Measurement Result:

Channel	Packet	Dwell Ti	me (ms)	Conclusion
	DH1	Fig.25	262.93	Р
39	DH3	Fig.26	343.07	Р
	DH5	Fig.27	359.20	Р

Conclusion: PASS B.7 20dB Bandwidth

Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247(a)(1)	NA *

^{*} Comment: This test case is not required according to the latest FCC 47 CFR Part 15.247. But the test results are necessary for "carrier frequency separation" test case, in Annex B.8.

Measurement Results:

Channel	20dB Bandwidth (kHz)		Conclusion		
0	Fig.28	969.48	NA		
39	Fig.29	924.80	NA		
78	Fig.30	924.80	NA		

Conclusion: NA

B.8 Carrier Frequency Separation

Measurement Limit:

Standard	Limit(kHz)		
FCC 47 CFR Part 15.247(a)(1)	>616.21		

 $^{^{*}}$ Comment: This limit should be over 25 kHz or (2/3) * 20dB bandwidth, whichever is greater. The value of (2/3) * 20dB bandwidth (value of channel 39 is 924.80 kHz) is 616.21 kHz, and it is greater than 25 kHz.

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Measurement Result:

Channel	Carrier frequency	Conclusion	
39	Fig.31	1024.04	Р

Conclusion: PASS

B.9 Number of Hopping Channels

Measurement Limit:

Standard	Limit
FCC 47 CFR Part 15.247(a) (1)(iii)	> 75

Measurement Result:

Channel	Number of hop	Conclusion	
0~39	Fig.32	70	В
40~78	Fig.33	- 79	F

Conclusion: PASS

B.10 AC Powerline Conducted Emission

Test Condition

Voltage (V)	Frequency (Hz)
110	60

Measurement Result and limit:

Bluetooth (Quasi-peak Limit)

Frequency range	Quasi-peak	Result (dBμV)	Conclusion
(MHz)	Limit (dBμV)	With charger	Conclusion
0.15 to 0.5	66 to 56		
0.5 to 5	56	Fig. 34	Р
5 to 30	60		

NOTE: The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Bluetooth (Average Limit)

Frequency range	_	, ,	Conclusion
(MHz)	(dBμV)	With charger	
0.15 to 0.5	56 to 46		
0.5 to 5	46	Fig. 34	Р
5 to 30	50		

NOTE: The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

Conclusion: PASS

ANNEX C: TEST FIGURE LIST

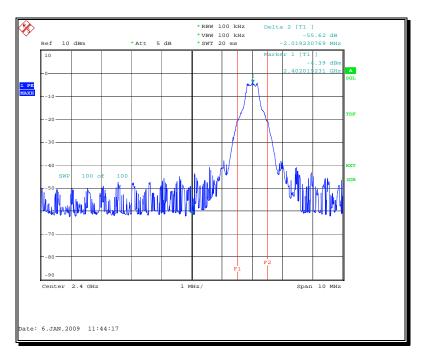


Fig. 1 Frequency Band Edges: Channel 0, Hopping Off

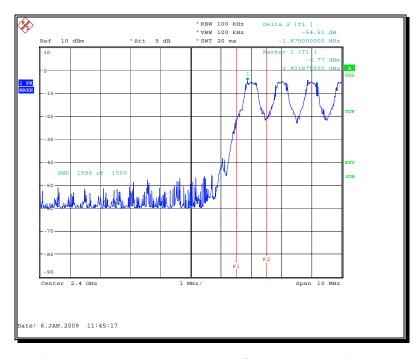


Fig. 2 Frequency Band Edges: Channel 0, Hopping On

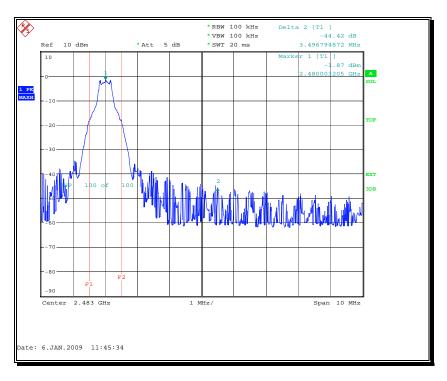


Fig. 3 Frequency Band Edges: Channel 78, Hopping Off

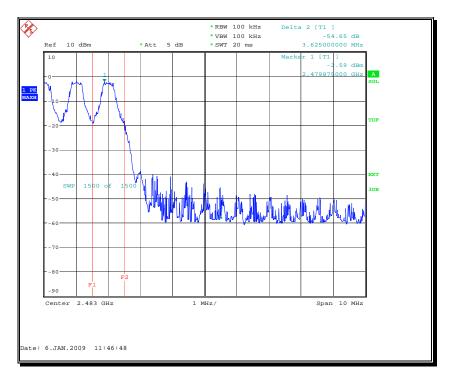


Fig. 4 Frequency Band Edges: Channel 78, Hopping On

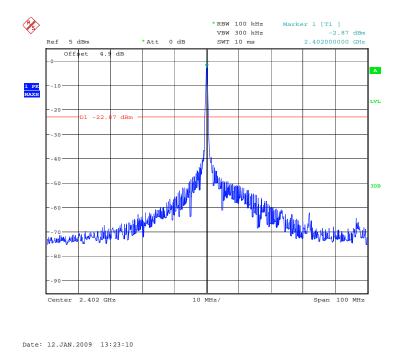


Fig. 5 Conducted spurious emission: Channel 0,2402MHz

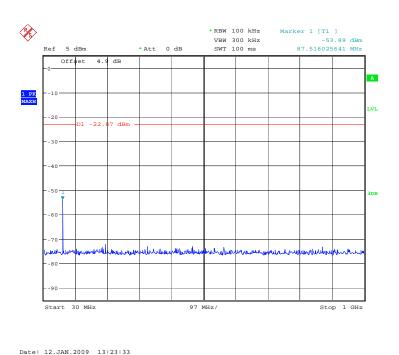


Fig. 6 Conducted spurious emission: Channel 0, 30MHz - 1GHz

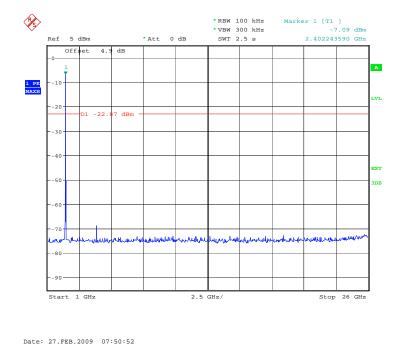


Fig. 7 Conducted spurious emission: Channel 0,1GHz – 26GHz

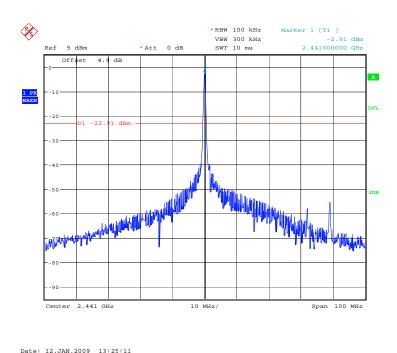


Fig. 8 Conducted spurious emission: Channel 39, 2441MHz

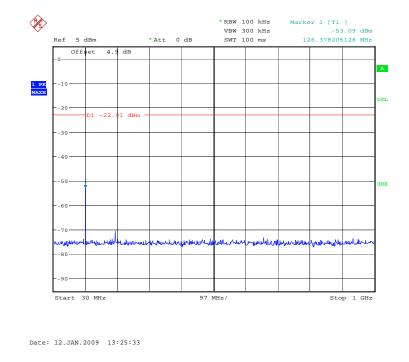


Fig. 9 Conducted spurious emission: Channel 39, 30MHz - 1GHz

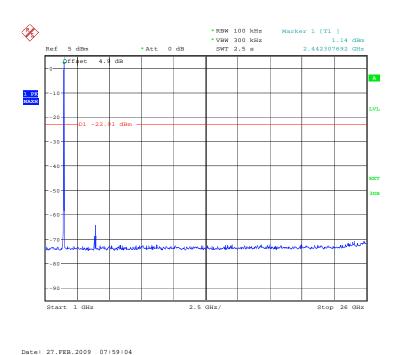


Fig. 10 Conducted spurious emission: Channel 39, 1GHz - 26GHz

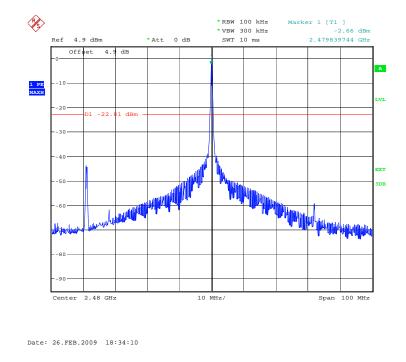


Fig. 11 Conducted spurious emission: Channel 78, 2480MHz

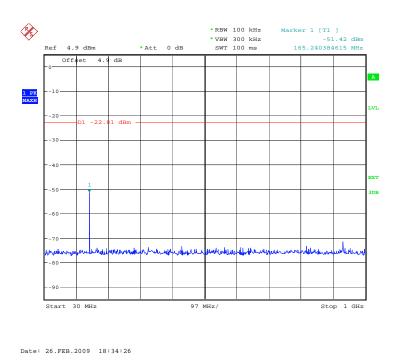


Fig. 12 Conducted spurious emission: Channel 78, 30MHz - 1GHz

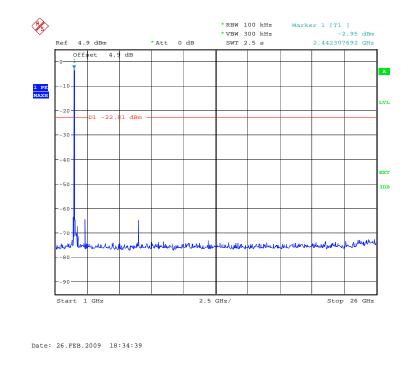


Fig. 13 Conducted spurious emission: Channel 78, 1GHz - 26GHz

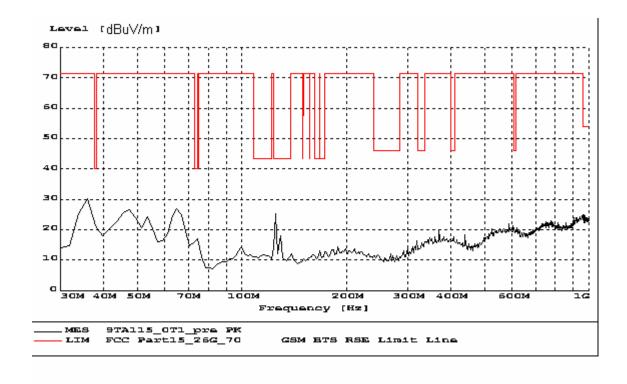


Fig. 14 Radiated emission: Channel 0, 30 MHz ~ 1 GHz

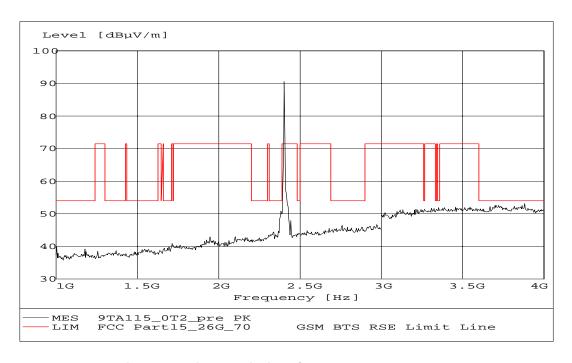


Fig. 15 Radiated emission: Channel 0, 1 GHz ~ 4 GHz

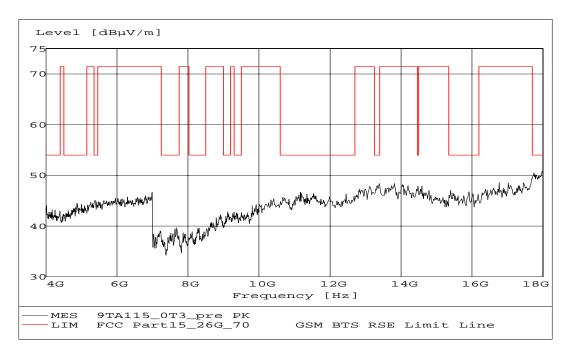


Fig. 16 Radiated emission: Channel 0, 4 GHz ~ 18 GHz

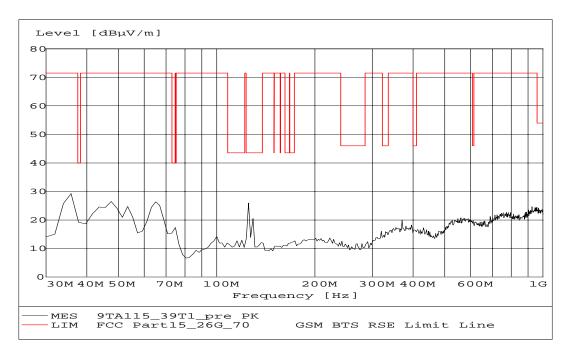


Fig. 17 Radiated emission: Channel 39, 30 MHz ~ 1 GHz

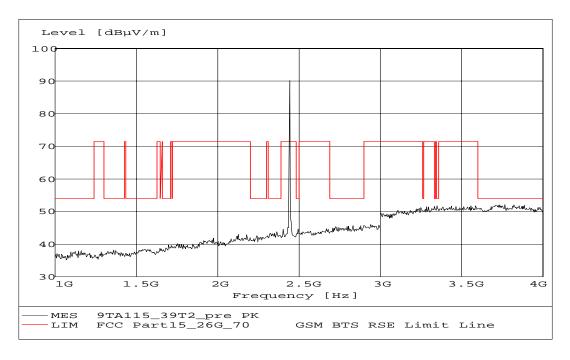


Fig. 18 Radiated emission: Channel 39, 1 GHz ~ 4 GHz

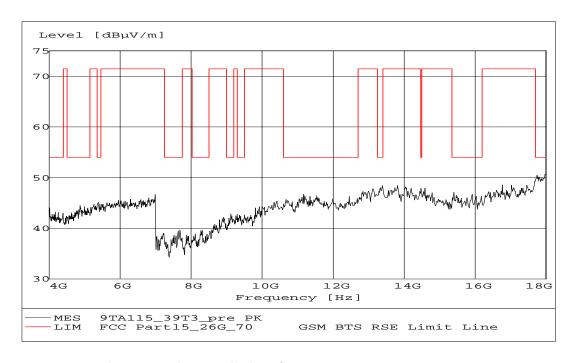


Fig. 19 Radiated emission: Channel 39, 4 GHz ~ 18 GHz

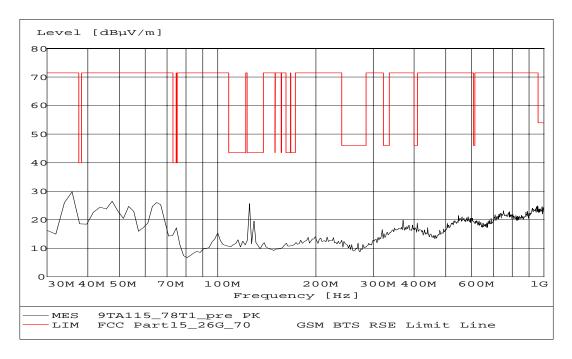


Fig. 20 Radiated emission: Channel 78, 30 MHz ~ 1 GHz

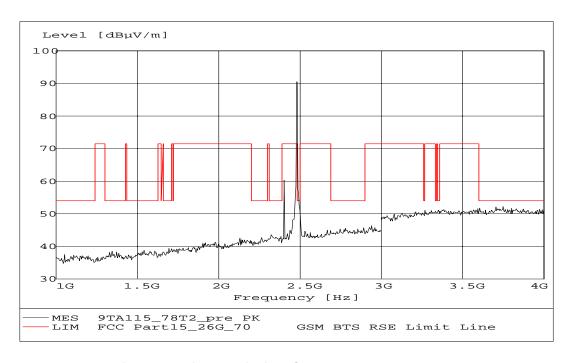


Fig. 21 Radiated emission: Channel 78, 1 GHz ~ 4 GHz

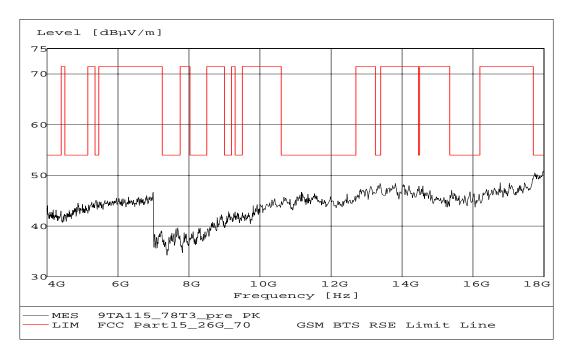


Fig. 22 Radiated emission: Channel 78, 4 GHz ~ 18 GHz

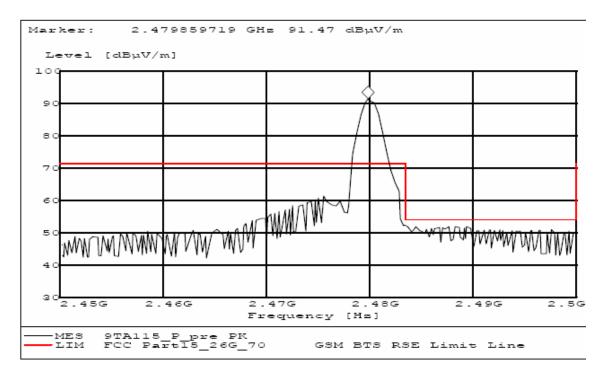


Fig. 23 Radiated emission (Power): channel 78, 2.45GHz ~ 2.5GHz

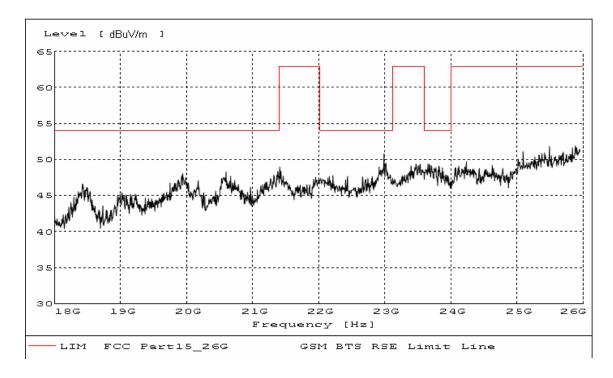


Fig. 24 Radiated emission: 18 GHz ~ 26 GHz

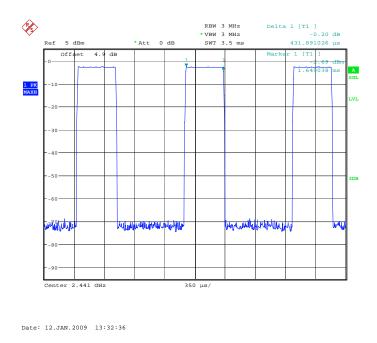


Fig. 25 Time of occupancy (Dwell Time): Channel 39, Packet DH1

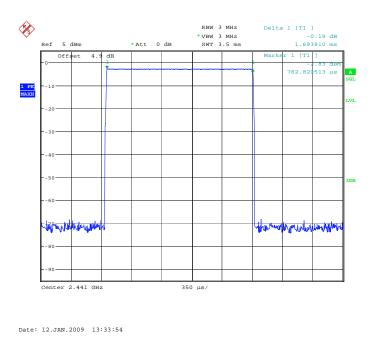


Fig. 26 Time of occupancy (Dwell Time): Channel 39, Packet DH3



Fig. 27 Time of occupancy (Dwell Time): Channel 39, Packet DH5

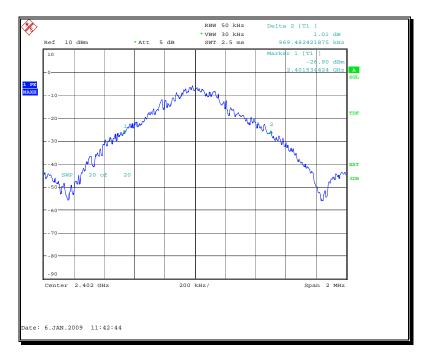


Fig. 28 20dB Bandwidth: Channel 0

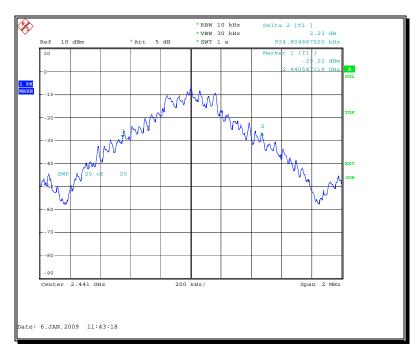


Fig. 29 20dB Bandwidth: Channel 39

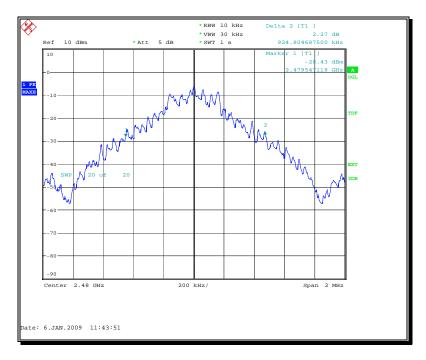


Fig. 30 20dB Bandwidth: Channel 78

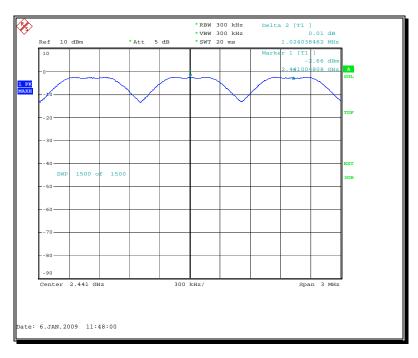


Fig. 31 Carrier frequency separation measurement: Channel 39

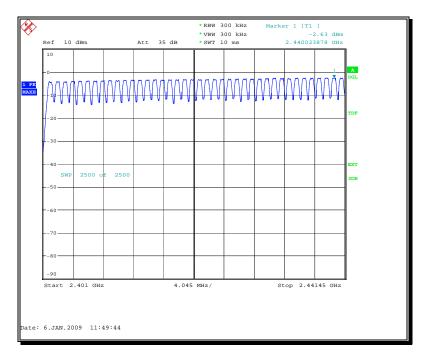


Fig. 32 Number of hopping frequencies: Channel 0 – 39

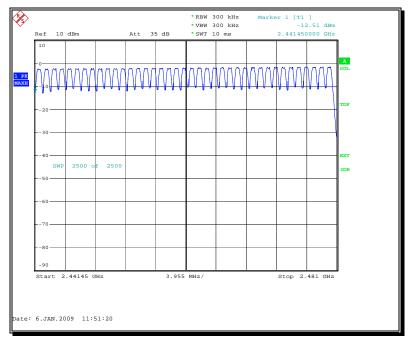


Fig. 33 Number of hopping frequencies: Channel 40 - 78

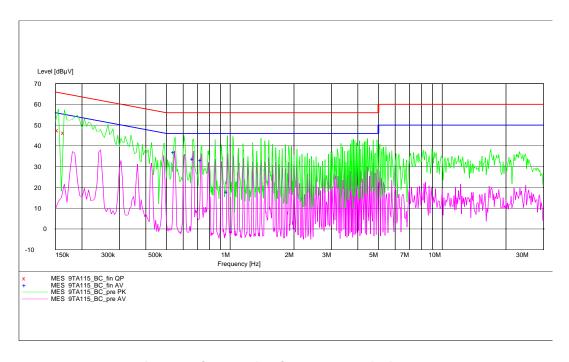


Fig. 34 AC Powerline Conducted Emission

MEASUREMENT RESULT - QP

Frequency (MHz)	Level (dBµV)	Transd (dB)	Limit (dBµV)	Margin (dB)	Line	PE
0.155000	47.60	10.1	66	18.1	Ν	FLO
0.165000	46.40	10.1	65	18.8	N	GND

MEASUREMENT RESULT - AV

Frequency (MHz)	Level (dBµV)	Transd (dB)	Limit (dBµV)	Margin (dB)	Line	PE
0.545000	36.90	10.1	46	9.1	L1	FLO
0.670000	33.70	10.1	46	12.4	L1	GND
0.730000	33.20	10.1	46	12.8	L1	GND
0.970000	17.80	10.1	46	28.2	L1	GND

ANNEX D: TEST LAYOUT



Photo of Radiated Emission Test

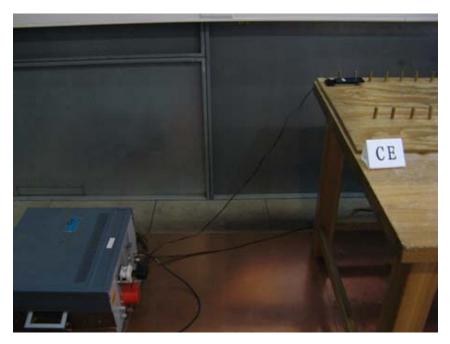


Photo of AC Powerline Conducted Emission Test

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